

Notice of References Cited	Application/Control No. 10/653,719		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner John P. Leubecker		Art Unit 3739	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,765,561	06-1998	Chen et al.	600/407
*	C	US-5,704,897	01-1998	Truppe, Michael J.	600/117
*	D	US-5,558,619	09-1996	Kami et al.	600/146
*	E	US-5,526,814	06-1996	Cline et al.	600/411
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*	G	US-5,491,510	02-1996	Gove, Robert J.	348/77
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*	J	US-5,153,721	10-1992	Eino et al.	382/152
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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